Wide-field, high-resolution lensless on-chip microscopy via near-field blind ptychographic modulation

SHAOWEI JIANG,1,3 JIAKAI ZHU,1,3 CHENGFEI GUO,1 ZICHAO BIAN,1 PENGMING SONG,2 RUIHAI WANG,1 HE ZHANG,1,* AND GUOAN ZHENG1,2,*

1Department of Biomedical Engineering, University of Connecticut, Storrs, CT, 06269, USA
2Department of Electrical and Computer Engineering, University of Connecticut, Storrs, CT, 06269, USA
3These authors contributed equally to this work
*Corresponding author: he.zhang@uconn.edu or guoan.zheng@uconn.edu

Date: 10/02/2019

We report a novel lensless on-chip microscopy platform for large field-of-view and high-resolution imaging. In this platform, we place a thin diffuser in between the object and the image sensor for lightwave modulation. By blindly scanning the unknown diffuser to different x-y positions, we acquire a sequence of modulated intensity images for object recovery. Different from previous ptychographic implementations, we employ a unit magnification configuration with a Fresnel number of ~50,000, which is orders of magnitude higher than previous ptychographic setups. The unit magnification configuration allows us to have the entire sensor area, 6.4 mm by 4.6 mm, as the imaging field of view. The ultra-high Fresnel number enables us to directly recover the positional shift of the diffuser in the phase retrieval process, addressing the positioning accuracy issue plagued in regular ptychographic experiments. We employ an up-sampling phase retrieval scheme to bypass the resolution limit set by the pixel size of the image sensor. We demonstrate a half-pitch resolution of 0.78 µm and test the imaging performance using various confluent biological samples. We also demonstrate 3D digital refocusing of a thick sample based on the recovered object wavefront.

Optical microscope platform with high numerical aperture (NA) objective lens has long been used for microscale bioimaging. In contrast, lensless microscopy enables high-resolution imaging without using any lens. Various lensless imaging platforms have been reported in the past years [1-13]. For direct shadow imaging, the sample is placed on top of the active sensing area of the imager and the object intensity information can be recovered via simple filtered back projection [8]. For other lensless implementations, there is typically a propagation distance between the object and the image sensor. Therefore, the captured intensity images are coherent diffraction patterns of the complex object. For weakly scattering and sparse objects, the principle of digital in-line holography can be used to recover the image [1]. Under more general consideration where a clean reference wave is not present, a phase retrieval process is needed to recover the complex object. Multiple object heights [5], multiple incident angles [6, 10, 13], and multiple wavelengths [9, 14] can be used in the acquisition process to introduce diversity to the phase retrieval problem. Recently, we have also demonstrated the use of a translated unknown speckle pattern for lensless phase retrieval [11]. For different implementations of lensless on-chip imaging, we refer the interested readers to the review papers by Ozcan and colleagues [15].

In this letter, we report a novel lensless on-chip microscopy platform for large field-of-view and high-resolution imaging. In this platform, we place a thin diffuser in between the object and the image sensor for lightwave modulation. By blindly scanning the unknown diffuser to different x-y positions, we acquire a sequence of modulated intensity images for object recovery. This platform shares its root with ptychography, a lensless imaging approach with transverse translation diversity [11, 13, 16-20]. Different from previous ptychographic implementations, we employ a unit magnification configuration with a Fresnel number of ~50,000. The unit magnification configuration allows us to have the entire sensor area, 6.4 mm by 4.6 mm, as the imaging field of view. The ultra-high Fresnel number enables us to directly recover the positional shift of the diffuser in the phase retrieval process, addressing the positioning accuracy issue plagued in regular ptychographic experiments [21]. Unlike the illumination-based approach [7, 11, 16, 17], the recovered image of our platform only depends upon how the complex wavefront exits the sample. Therefore, the sample thickness becomes irrelevant during reconstruction. After recovery, we can propagate the complex wavefront to any position along the optical axis.

Our prototype setup is shown in Fig. 1, where we use a 50-mW, 532-nm fiber-coupled laser diode for illumination. We make a thin diffuser by coating ~1 µm polystyrene beads on a coverslip and place it in between the object and the image sensor for lightwave modulation. The resulting modulated intensity patterns are then captured by the image.
sensor. In this setup, the distance between the object and the image sensor is ~1 mm, corresponding to a Fresnel number of ~50,000. To the best of our knowledge, the Fresnel number of our platform is the highest one among various ptychographic experiments, enabling wide-field-of-view and high-resolution imaging at the same time.

![Near-field blind ptychographic diffuser modulation](image)

Fig. 1. Lensless on-chip microscopy via near-field blind ptychographic diffuser modulation. In this platform, we place a thin diffuser in between the object and the image sensor for lightwave modulation. The distance between the object and the image sensor is ~1 mm, corresponding to a Fresnel number of ~50,000. The unit magnification configuration allows us to have the entire sensor area, 6.4 mm by 4.6 mm, as the imaging field of view. The ultra-high Fresnel number enables us to directly recover the positional shift of the diffuser in the phase retrieval process.

In the acquisition process, we blindly scan the diffuser to different x-y positions and acquire the modulated intensity images using an image sensor (MT9J003 ON Semiconductor, 1.67 μm pixel size). We term this scheme ‘near-field blind ptychographic modulation’, where the word ‘blind’ has twofold implications. First, it implies the recovery of both the high-resolution complex object and the diffuser profile at the same time, similar to the recovery of both probe and object in blind ptychography [18, 22]. Second, it means we do not have any prior information of the positional shift of the diffuser. This second point, to the best of our knowledge, is new in ptychographic implementations, where precise positional information is typically required. The positional accuracy problem plagued in regular ptychography has generated considerable interests in developing algorithms to refine the positional shift during the phase retrieval process [21]. However, these approaches may fail if a good initial guess of the shift is not available. Thanks to the ultrahigh Fresnel number, we can directly recover the positional shift with sub-pixel accuracy. Low-cost random scanning system can be used in the reported platform without any positioning accuracy requirement [23].

The forward imaging model of our platform can be expressed as

\[
I_j(x, y) = |O(x, y) \ast PSF_{free}(d_1) \cdot D(x - x_j, y - y_j) \ast PSF_{pixel}|^2 \tag{1}
\]

where \(I_j(x, y)\) is the \(j\)th intensity measurement \((j = 1, 2, \ldots, J)\), \(O(x, y)\) is the complex exit wavefront of the object, \(D(x, y)\) is the complex profile of the diffuser, \((x_j, y_j)\) is the \(j\)th positional shift of the diffuser, \(\ast\) stands for point-wise multiplication, and \(\ast\ast\) denotes convolution operation. In Eq. (1), \(d_1\) is the distance between the object and the diffuser, and \(d_2\) is the distance between the diffuser and the image sensor. We use \(PSF_{free}(d)\) to model the point spread function (PSF) for free-space propagation over distance \(d\), and \(PSF_{pixel}\) to model the PSF of the pixel response. Due to the relatively large pixel size, the captured image is a down-sampled version of the diffraction pattern, and we use \(\downarrow M\) in the subscript of Eq. (1) to represent the down-sampling process \(M = 3\) in our implementation. Based on all captured images \(I_j\) with the diffuser scanned to different lateral positions \((x_j, y_j)\), we aim to recover the complex exit wavefront of the object \(O(x, y)\) and the diffuser profile \(D(x, y)\).

**Algorithm outline**

**Input:** Raw images \(I_j (j = 1, 2, \ldots, J)\) with the translational shift of the diffuser

**Output:** High-resolution object \(O(x, y)\) and the diffuser profile \(D(x, y)\)

1. Calculate the translational shift \((x_j, y_j)\) of the diffuser using cross-correlation
2. Initialize \(O(x, y)\) and \(D(x, y)\)
3. \(O(x, y) = PSF_{free}(d_1) \ast O(x, y)\) % Propagate the wavefront to the diffuser
4. for \(m = 1: N\) (different iterations)
5. for \(j = 1: J\) (different captured images)
6. \(D_j(x, y) = D(x - x_j, y - y_j)\) % Shift the diffuser to \((x_j, y_j)\) position
7. \(\psi_j(x, y) = O(x, y) \ast D_j(x, y)\)
8. \(\psi_j(x, y) = PSF_{free}(d_2) \ast \psi_j(x, y)\)
9. Update \(\psi_j(x, y)\) using Eq. (2) % Up-sampled magnitude projection
10. \(\psi^\prime_j(x, y) = PSF_{free}(d_2) \ast \psi_j(x, y)\)
11. Update the object using Eq. (3)
12. Update the diffuser using Eq. (4)
13. \(D(x, y) = D^\prime(x + x_j, y + y_j)\) % Shift back the updated diffuser
14. end
15. end
16. \(O(x, y) = PSF_{free}(d_1) \ast O^\prime(x, y)\) % Propagate back to the object plane

The recovery process is shown in Fig. 2. We first recover the positional shift the diffuser using cross-correlation. We then initialize the amplitude of the object by averaging all measurements. The diffuser profile is initialized to an all-one matrix. In the iterative reconstruction process, we propagate the object to the diffuser plane and obtain \(\psi_j\) in line 7. At the detector plane, we use the following equation to update the exit wave \(\psi_j(x, y)\):

\[
\psi_j^\prime(x, y) = \psi_j(x, y) \frac{I_j(x, y) \downarrow M}{|\psi_j(x, y)|^2 + \text{ones}(M \times M) \downarrow M} \tag{2}
\]

In Eq. (2), the image sizes of \(\psi_j(x, y)\) and \(I_j(x, y)\) are different. If \(I_j\) has a size of 100 by 100 pixels, \(\psi_j\) will have 300 by 300 pixels (with an up-sampling factor \(M = 3\)). The term \(\psi_j(x, y) \downarrow M\) represents the nearest-neighbor up-sampling of the captured image \(I_j\). In the denominator of Eq. (2), we first convolute the term \(|\psi_j(x, y)|^2\) with an average filter \((M = M\) all one matrix). We then perform \(M\)-times down-sampling followed by \(M\)-times nearest-neighbor up-sampling. This updating process enforces the intensity summation of every \(M\) by \(M\) small pixels equals the corresponding large pixel in the captured image [24]. With the updated \(\psi_j'(x, y)\), we then update the object and the diffuser profiles via Eqs. (3) and (4) [25, 26]:

\[
O_j^{\text{update}}(x, y) = O(x, y) + \frac{\text{conj}(D_j(x, y)) \cdot \text{conj}(\psi_j'(x, y) - \psi_j(x, y))}{|\text{conj}(D_j(x, y))|^2 + \alpha_{\text{up}}|\text{conj}(\theta_j(x, y))|^2_{\text{max}}} \tag{3}
\]

\[
D_j^{\text{update}}(x, y) = D_j(x, y) + \frac{\text{conj}(O_j(x, y)) \cdot \text{conj}(\psi_j'(x, y) - \psi_j(x, y))}{|\text{conj}(O_j(x, y))|^2 + \alpha_{\text{up}}|\text{conj}(\theta_j(x, y))|^2_{\text{max}}} \tag{4}
\]
The processing time for 400 raw images with 1024 by 1024 pixels each is ~50 seconds for 2 iterations using a Dell XPS 8930 desktop computer.

We first validate the proposed lensless imaging scheme using a USAF resolution target in Fig. 3. Figure 3(a) shows the captured raw image of the resolution target, where the speckle feature comes from the diffuser modulation process. Figure 3(b) shows the recovered diffuser profile. Figure 3(c) shows our high-resolution recovery of the object, where we can resolve 0.78-µm linewidth of group 9, element 3 on the resolution target. The phase retrieval process converges within 2-3 iterations in all experiments reported in this letter.

In the second experiment, we validate the reported approach using a quantitative phase imaging nature of the reported approach. A quantitative phase target (Benchmark QPT) is used as the object. Figure 4(a) shows the captured raw image with diffuser modulation. Figure 4(b) shows the recovered quantitative phase using the reported platform. The line profile across the red dash arc in Fig. 4(b) is plotted in the inset. The recovered phase is in good agreement with the ground-truth of the phase target. We have also tested the phase imaging performance using an unstained mouse kidney slide in Fig. 5, where Fig. 5(a) shows the captured raw image and Fig. 5(b) shows the recovered quantitative phase of the slide.

In the third experiment, we test the reported approach with a thick potato sample. Figure 6(a) shows the recovered amplitude of the object exit wavefront. Figure 6(b1)-6(b3) show the recovered object amplitude after digitally propagating to $z = 620$ µm, $z = 650$ µm and $z = 685$ µm (also refer to Visualization 1). We can see that the cell walls are in focus in Fig. 6(b1) and the organelles are in focus in Fig. 6(b2) and 6(b3).

In many microscopy applications, it is important to achieve both high-resolution and wide field of view at the same time. The unit magnification configuration allows us to have the entire sensor area, 6.4 mm by 4.6 mm, as the imaging field of view. We validate the wide-field-of-view and high-resolution imaging performance using a stained esophagus cancer slide in Fig. 7. Figure 7(a) shows the full field of view of the recovered amplitude of the object. Figure 7(b)-7(d) show the magnified recovered amplitude and phase of the three highlighted regions in Fig. 7(a).
In summary, we report a novel lensless on-chip imaging platform for wide-field, high-resolution microscopy. In this platform, we place a thin diffuser in between the object and the image sensor for lightwave modulation. By blindly scanning the unknown diffuser to different x-y positions, we acquire a sequence of modulated intensity images for object recovery. We demonstrate a half-pitch resolution of 0.78 µm and test the imaging performance using various confluent biological samples. We also demonstrate 3D digital refocusing of a thick sample based on the recovered object wavefront.

There are several unique advantages of the reported platform. First, different from previous ptychographic implementations, the unit magnification configuration allows us to have the entire sensor area, 6.4 mm by 4.6 mm, as the imaging field of view. Second, thanks to the ultra-high Fresnel number, the speckle feature from the diffuser can be clearly resolved from the captured intensity images. Therefore, we can directly recover the unknown positional shifts via image cross-correlation. Precise mechanical scanning that is critical in conventional ptychography experiments is no longer needed in our implementation. Third, different from the pixel super-resolution technique employed in conventional lensless on-chip imaging setups [15], the reported platform can achieve sub-pixel resolution using an up-sampling phase retrieval scheme. Fourth, since we modulate the light wave at the detection path, the recovered image only depends upon how the complex wavefront exits the sample. The sample thickness becomes irrelevant during reconstruction. After recovery, we can propagate the complex wavefront to any position along the optical axis. Lastly, our phase retrieval process typically converges within 2-3 iterations, which are much faster than regular ptychographic implementations. This may be due to the ultrahigh Fresnel number of our setup. Further research along this line is highly desired.

Funding. This work is supported by UConn SPARK grant and National Science Foundation 1510077.

References
15. A. Ozcan and E. McLeod, Annual review of biomedical engineering 18, 77-102 (2016).